

IRLS3036-7PPBF-VB Datasheet N-Channel 60 V (D-S) 175 °C MOSFET

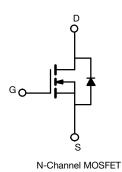
| PRODUCT SUMMARY | | | | |
|---|-----------|--|--|--|
| V _{DS} (V) | 60 | | | |
| $R_{DS(on)}(\Omega)$ at $V_{GS} = 10 \text{ V}$ | 0.00163 | | | |
| I _D (A) | 150 | | | |
| Configuration | Single | | | |
| Package | TO-263-7L | | | |

FEATURES

- Trench power MOSFET
- Package with low thermal resistance
- 100 % R_g and UIS tested







| ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted) | | | | | |
|--|-------------------------|-----------------------------------|------------------|------|--|
| PARAMETER | | SYMBOL | LIMIT | UNIT | |
| Drain-source voltage | | V_{DS} | 60 | V | |
| Gate-source voltage | | V_{GS} | ± 20 | | |
| Continuous drain current | T _C = 25 °C | - I _D | 150 | | |
| | T _C = 125 °C | | 120 ^a | | |
| Continuous source current (diode conduction) a | | I _S | 120 | Α | |
| Pulsed drain current ^b | | I _{DM} | 400 | | |
| Single pulse avalanche current | L = 0.1 mH | I _{AS} | 75 | | |
| Single pulse avalanche energy | L=0.11IIII | E _{AS} | 281 | mJ | |
| Maximum power dissipation ^b | T _C = 25 °C | D | 375 | W | |
| | T _C = 125 °C | - P _D | 125 | VV | |
| Operating junction and storage temperature range |) | T _J , T _{stg} | -55 to +175 | °C | |

| THERMAL RESISTANCE RATINGS | | | | | |
|----------------------------|-------------|------------|-------|------|--|
| PARAMETER | | SYMBOL | LIMIT | UNIT | |
| Junction-to-ambient | PCB mount c | R_{thJA} | 40 | °C/W | |
| unction-to-case (drain) | | R_{thJC} | 0.4 | C/VV | |

Notes

- a. Package limited
- b. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %
- c. When mounted on 1" square PCB (FR4 material)



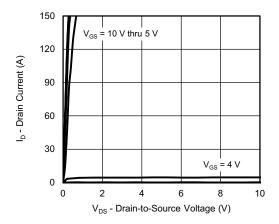
| PARAMETER | SYMBOL | TES | T CONDITIONS | MIN. | TYP. | MAX. | UNIT | |
|---|-------------------------|--|---|------|---------|--------|------|--|
| Static | | | | | | | | |
| Drain-source breakdown voltage | V _{DS} | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | | 60 | - | - | V | |
| Gate-source threshold voltage | V _{GS(th)} | V _{DS} = | $V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$ | | 3.0 | 3.5 | V | |
| Gate-source leakage | I _{GSS} | V _{DS} = | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ | | - | ± 100 | nA | |
| Zero gate voltage drain current | I _{DSS} | $V_{GS} = 0 V$ | V _{DS} = 60 V | - | - | 1 | | |
| | | V _{GS} = 0 V | V _{DS} = 60 V, T _J = 125 °C | - | - | 50 | μA | |
| | | V _{GS} = 0 V | V _{DS} = 60 V, T _J = 175 °C | - | - | 250 | μΑ | |
| On-state drain current a | I _{D(on)} | V _{GS} = 10 V | $V_{DS} \ge 5 V$ | 120 | - | 1 | Α | |
| Drain-source on-state resistance ^a | | V _{GS} = 10 V | I _D = 30 A | - | 0.00163 | - | Ω | |
| | R _{DS(on)} | V _{GS} = 10 V | I _D = 30 A, T _J = 125 °C | - | 0.00300 | - | | |
| | | V _{GS} = 10 V | I _D = 30 A, T _J = 175 °C | - | 0.00360 | 1 | | |
| Forward transconductance b | 9 _{fs} | V _{DS} = 15 V, I _D = 30 A | | - | 142 | ı | S | |
| Dynamic ^b | | | | | | | | |
| Input capacitance | C _{iss} | V _{GS} = 0 V | 0 V V _{DS} = 25 V, f = 1 MHz | - | 9100 | 11 900 | pF | |
| Output capacitance | C _{oss} | | | - | 3550 | 4700 | | |
| Reverse transfer capacitance | C _{rss} | | | - | 160 | 220 | | |
| Total gate charge ^c | Qg | | 0 V V _{DS} = 30 V, I _D = 50 A | - | 123 | 185 | nC | |
| Gate-source charge ^c | Q _{gs} | V _{GS} = 10 V | | - | 40 | - | | |
| Gate-drain charge ^c | Q _{gd} | | | - | 19 | - | | |
| Gate resistance | R_g | f = 1 MHz | | 4 | 8.6 | 13 | Ω | |
| Turn-on delay time ^c | t _{d(on)} | | | - | 48 | 75 | | |
| Rise time ^c | t _r | V_{DD} = 30 V, R_L = 0.6 Ω I_D \cong 50 A, V_{GEN} = 10 V, R_g = 1 Ω | | - | 26 | 40 | ns | |
| Turn-off delay time c | t _{d(off)} | | | - | 105 | 160 | | |
| Fall time ^c | t _f | | | - | 25 | 40 | | |
| Source-Drain Diode Ratings and Chara | cteristics ^b | | | | | | | |
| Pulsed current ^a | I _{SM} | | | - | - | 240 | А | |
| Forward voltage | V _{SD} | $I_F = 50 \text{ A}, V_{GS} = 0 \text{ V}$ | | - | 0.84 | 1.5 | V | |
| Body diode reverse recovery time | t _{rr} | I _F = 25 A, di/dt = 100 A/μs | | - | 100 | 200 | ns | |
| Body diode reverse recovery charge | Q _{rr} | | | - | 243 | 500 | nC | |
| Reverse recovery fall time | ta | | | - | 48 | - | | |
| Reverse recovery rise time | t _b | | | - | 53 | - | ns | |
| Body diode peak reverse recovery current | I _{RM(REC)} | | | - | -4.6 | - | Α | |

Notes

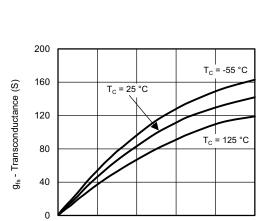
- a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 % b. Guaranteed by design, not subject to production testing c. Independent of operating temperature



TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)



Output Characteristics

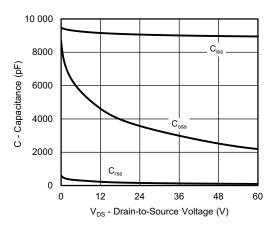


Transconductance

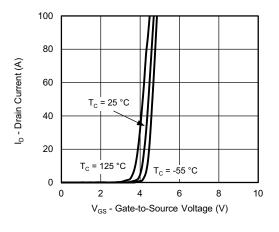
I_D - Drain Current (A)

24

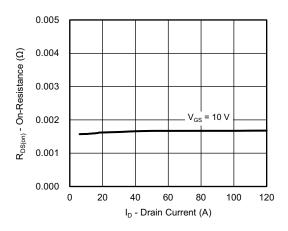
30



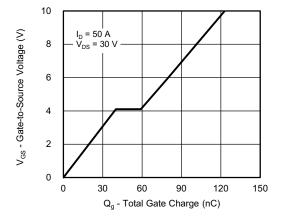
Capacitance



Transfer Characteristics



On-Resistance vs. Drain Current



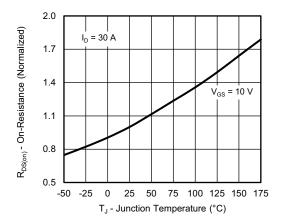
Gate Charge

0

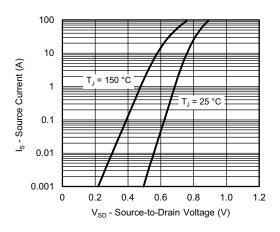
6



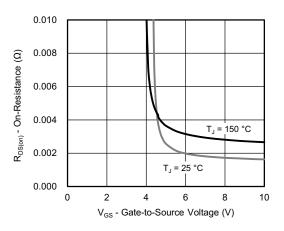
TYPICAL CHARACTERISTICS (T_A = 25 °C, unless otherwise noted)



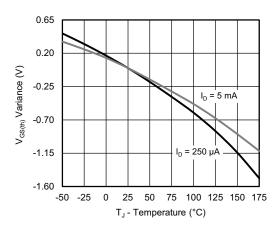
On-Resistance vs. Junction Temperature



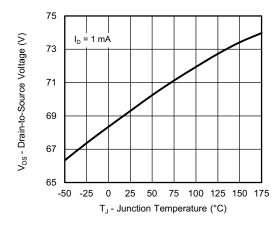
Source Drain Diode Forward Voltage



On-Resistance vs. Gate-to-Source Voltage



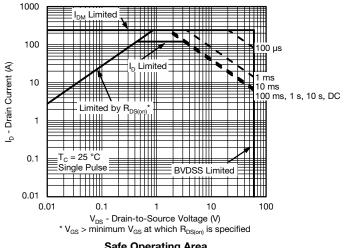
Threshold Voltage



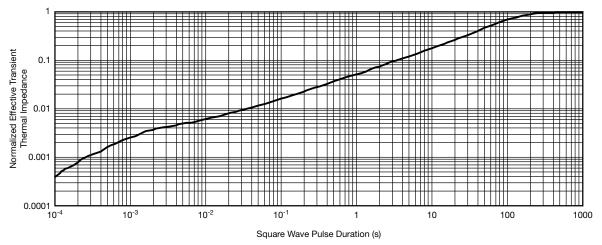
Drain Source Breakdown vs. Junction Temperature



THERMAL RATINGS ($T_A = 25$ °C, unless otherwise noted)



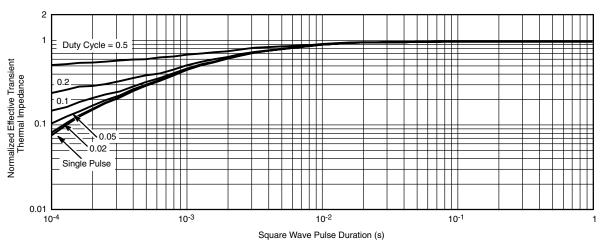
Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Ambient



THERMAL RATINGS ($T_A = 25$ °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case

Note

- The characteristics shown in the two graphs
 - Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)
 - Normalized Transient Thermal Impedance Junction-to-Case (25 °C)

are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions



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